Search Notes

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10/657,796 Examiner

David E. Bochna

Applicant(s)/Patent under Reexamination

KURIHARA ET AL.

Art Unit

3679

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
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285	423	1/4/2006	DB		
	141.1				

SEARCH NO (INCLUDING SEARC)
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